

## 1.0 SCOPE

- 1.1** This specification covers the detail requirements for a precision voltage reference that provides a stable +10V output and can be adjusted over a  $\pm 3\%$  range with minimal effect on temperature stability. This circuit is processed in accordance with MIL-STD-883 and is fully compliant to paragraph 1.2.1.

It is highly recommended that this data sheet be used as a baseline for new military or aerospace source control drawings.

For typical applications and operating characteristics, consult Maxim's data books.

## 1.2 Part Numbers

Device	Part Number
-1	REF-01A(X)/883B
-2	REF-01(X)/883B

## 1.3 Package

(X)	Package	Description
J	TV	8-Pin (TO-99)
Z	JA	8-Pin Ceramic Dual-In-Line Package (CERDIP)
RC	L-20	20-Pin Ceramic Leadless Chip Carrier (LCC)

**Note:** See *Package Information* section for package drawings and dimensions.

## 1.4 Absolute Maximum Ratings

( $T_A = +25^\circ\text{C}$ , unless otherwise noted.)

Input Voltage . . . . .	40V
Output Short-Circuit Duration (to GND or $V_{IN}$ ) . . . . .	Indefinite
Power Dissipation ( $T_A = +70^\circ\text{C}$ , $T_j = +150^\circ\text{C}$ )	
8-Pin TO-99 (derate 6.67mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$ ) . . . . .	533mW
8-Pin CERDIP (derate 8.00mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$ ) . . . . .	640mW
20-Pin LCC (derate 9.09mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$ ) . . . . .	727mW
Operating Temperature Range . . . . .	-55°C to +125°C
Storage Temperature Range . . . . .	-65°C to +150°C
Lead Temperature (soldering, 10 sec) . . . . .	+300°C

## 1.5 Thermal Resistance

- $\Theta_{JC} = 45^\circ\text{C/W}$  for TV
- $\Theta_{JC} = 55^\circ\text{C/W}$  for JA
- $\Theta_{JC} = 45^\circ\text{C/W}$  for LP
- $\Theta_{JA} = 150^\circ\text{C/W}$  for TV
- $\Theta_{JA} = 125^\circ\text{C/W}$  for JA
- $\Theta_{JA} = 150^\circ\text{C/W}$  for LP

# +10V Precision Voltage Reference

## 2.0 REQUIREMENTS

- 2.1** Electrical performance characteristics are specified in Table 1 and apply over the full ambient operating temperature range, unless otherwise specified.

**TABLE 1. ELECTRICAL PERFORMANCE CHARACTERISTICS (Note 1)**

CHARACTERISTICS	SYMBOL	CONDITIONS	DEVICE TYPES	GROUP A SUB-GROUPS	LIMITS	UNITS	
					MIN	MAX	
Quiescent Supply Current	I <sub>IN</sub>	No load	-1, -2	1	1.4	mA	
				2, 3	2.0		
Output Adjustment Range	ΔV <sub>TRIM</sub>	R <sub>P</sub> = 10kΩ	-1, -2	1	-3.0	3.0	%
Output Voltage	V <sub>O</sub>	I <sub>L</sub> = 0mA	-1	1	9.970	10.030	V
				2, 3	9.955	10.045	
			-2	1	9.950	10.050	
				2, 3	9.905	10.095	
Short-Circuit Current	I <sub>SC</sub>	V <sub>O</sub> = 0V	-1, -2	1	15	60	mA
Sink Current	I <sub>S</sub>		-1, -2	1	-0.3	.	mA
Load Regulation (Note 2)	LD reg	I <sub>L</sub> = 0mA to 10mA	-1	1	0.008	%/mA	
				2, 3	0.012		
			-2	1	0.010		
				2, 3	0.015		
Line Regulation (Note 2)	LN reg	V <sub>IN</sub> = 13V to 33V	-1, -2	1	0.01	%/V	
				2, 3	0.015		
Load Current (Note 3)	I <sub>L</sub>		-1, -2	1	10	mA	
Output Voltage Noise	e <sub>np-p</sub>	0.1Hz to 10Hz	-1, -2	1	30	μVp-p	
Output Voltage Temperature Coefficient (Note 4)	TCV <sub>O</sub>		-1	1, 2, 3	-8.5	8.5	ppm/°C
					-25	25	

**Note 1:** V<sub>DD</sub> = +15V, V<sub>IN</sub> = +15V, unless otherwise noted.

**Note 2:** Line and load regulation specifications include the effect of self-heating.

**Note 3:** Minimum 10mA load current guaranteed by load regulation test.

**Note 4:** TCV<sub>O</sub> =  $\left(\frac{|V_{MAX} - V_{MIN}|}{10V}\right) \left(\frac{1}{180^\circ C} \times 10^6\right)$  where -55°C ≤ T<sub>A</sub> ≤ +125°C.

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**REF-01/883B**

## **3.0 QUALITY ASSURANCE**

- 3.1** Sampling and inspection procedures shall be in accordance with MIL-M-38510 and, to the extent specified, with MIL-STD-883.
- 3.2** Screening shall be in accordance with Method 5004 of MIL-STD-883. Burn-in test (Method 1015):  
(1) Test condition A, B, C, or D.  
(2)  $T_A = +125^\circ\text{C}$ , minimum.  
(3) Interim and final electrical test requirements shall be as specified in Table 2.
- 3.3** Quality conformance inspection shall be in accordance with Method 5005 of MIL-STD-883 including Groups A, B, C, and D inspection.  
Group A inspection:  
(1) Tests as specified in Table 2.  
(2) Selected subgroups in Table 1, Method 5005 of MIL-STD-883 shall be omitted.
- 3.4** Groups C and D inspections:  
a. End-point electrical parameters shall be specified in Table 1.  
b. Steady-state life test (Method 1005 of MIL-STD-883):  
(1) Test condition A, B, C, or D.  
(2)  $T_A = +125^\circ\text{C}$ , minimum.  
(3) Test duration, 1000 hours, except as permitted by Method 1005 of MIL-STD-883.

**TABLE 2. ELECTRICAL TEST REQUIREMENTS**

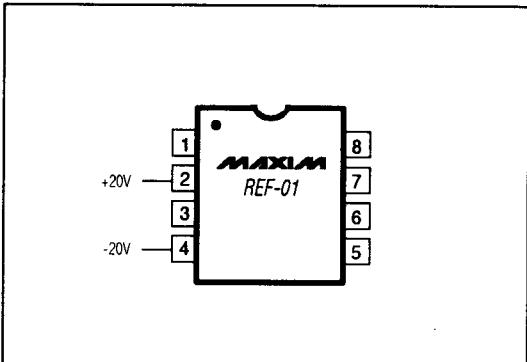
<b>MIL-STD-883 Test Requirements</b>	<b>Subgroups (per Method 5005, Table 1)</b>
Interim Electrical Parameters (Method 5004)	1
Final Electrical Parameters (Method 5004)	1, * 2, 3
Group A Test Requirements (Method 5005)	1, 2, 3
Groups C and D End-Point Electrical Parameters (Method 5005)	1

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\*PDA applies to Subgroup 1 only.

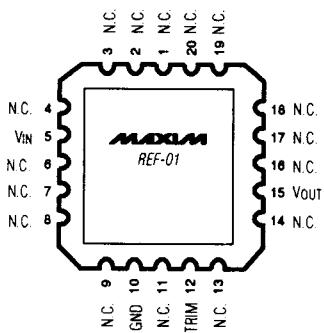
# +10V Precision Voltage Reference

## 4.0 Life Test/Burn-In Circuit

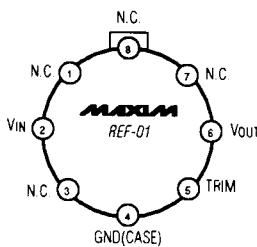


## 4.1 Pin Configurations

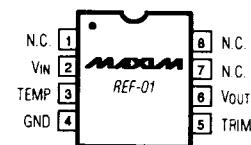
TOP VIEW



20-PIN LCC



8-PIN TO-99



8-PIN CERDIP

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## 4.2 Simplified Schematic and Pin Connections

